Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | WU ET AL. | Examiner | Art Unit | Vincent E. Kovalick | 2629 | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,643,124	11-2003	Wilk, Peter J.	361/681
*	В	US-2004/0266350	12-2004	Kim, Jae-Hyoung	455/041.2
*	С	US-2004/0264441	12-2004	Jalkanen et al.	370/352
*	D	US-2003/0098857	05-2003	Gettemy et al.	345/173
*	Е	US-2003/0058568	03-2003	YANAGITA, NOBORU	360/73.04
*	F	US-2003/0214612	11-2003	Freeman, Gary A.	349/12
*	G	US-2003/0160755	08-2003	Getterny et al.	345/156
	Ι	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*	<u> </u>	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.